Search Notes		

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/735,738	JUNG ET AL.	
Examiner	Art Unit	
Khanh V. Nguyen	2817	

	SEARCHED			
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INT	INTERFERENCE SEARCHED		
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	rch History ntout	10/12/2005	NKV

SEARCH NOT (INCLUDING SEARCH)
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EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	10/12/2005	NKV
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